

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/599,208	DELAHAYE, FRANCK	
Examiner		Art Unit		Page 1 of 1
Kin-Chan Chen		1792		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,506,260	01-2003	Hiraishi et al.	134/15
*	B	US-6,015,462	01-2000	Doolittle, James W.	118/668
*	C	US-6,391,145	05-2002	Nishimoto et al.	156/345.12
*	D	US-6,306,224	10-2001	Wandel et al.	134/32
*	E	US-2003/0194497	10-2003	Takada et al.	427/355
*	F	US-2004/0020905	02-2004	Song et al.	219/121.68
*	G	US-5,839,460	11-1998	Chai et al.	134/147
*	H	US-5,690,755	11-1997	Yoshinaga et al.	148/533
*	I	US-6,412,500	07-2002	Brunner et al.	134/64R
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.